Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination LEE, SUNG SUB	
10/630,956		
Examiner	Art Unit	
Sherrie Hsia	2622	

SEARCHED					
	SEAR	CHED			
Class	Subclass	Date	Examiner		
348	734, 725	6/67	gy		
340	825.72				
341	176, 173				
	180				
H04N	5/44	· · · · · · · · · · · · · · · · · · ·			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	6/07	sy	
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